
**Pritrjeni kondenzatorji za uporabo v elektronski opremi – 22. del: Področna
specifikacija: pritrjeni večplastni kondenzatorji za površinsko namestitev s
keramičnim dielektrikom, razred 2 (IEC 60384-22:2004 + popravek 2004)**

Fixed capacitors for use in electronic equipment – Part 22: Sectional specification:
Fixed surface mount multilayer capacitors of ceramic dielectric, Class 2 (IEC 60384-
22:2004 + corrigendum 2004)

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EUROPEAN STANDARD

EN 60384-22

NORME EUROPÉENNE

EUROPÄISCHE NORM

November 2004

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English version

Fixed capacitors for use in electronic equipment
Part 22: Sectional specification: Fixed surface mount multilayer
capacitors of ceramic dielectric, Class 2
(IEC 60384-22:2004 + corrigendum Sep. 2004)

Condensateurs fixes utilisés dans les
équipements électroniques
Partie 22: Spécification intermédiaire:
Condensateurs multicouches fixes pour
montage en surface pour diélectriques en
céramique, classe 2
(CEI 60384-22:2004 + corrigendum Sep.
2004)

Festkondensatoren zur Verwendung in
Geräten der Elektronik
Teil 22: Rahmenspezifikation:
Oberflächenmontierbare
Vielschichtkeramik-Festkondensatoren,
Klasse 2
(IEC 60384-22:2004 + corrigendum Sep.
2004)

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Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

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CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

Foreword

The text of document 40/1420/FDIS, future edition 1 of IEC 60384-22, prepared by IEC TC 40, Capacitors and resistors for electronic equipment, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 60384-22 on 2004-09-01.

This European Standard, together with EN 60384-21:2004, supersedes EN 132100:1996.

The following dates were fixed:

- latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2005-06-01
- latest date by which the national standards conflicting with the EN have to be withdrawn (dow) 2007-09-01

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 60384-22:2004 + corrigendum September 2004 was approved by CENELEC as a European Standard without any modification.

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Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE Where an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

| <u>Publication</u> | <u>Year</u> | <u>Title</u> | <u>EN/HD</u> | <u>Year</u> |
|----------------------|-------------|--|-------------------------------|--------------------|
| IEC 60063 | 1963 | Preferred number series for resistors and capacitors | - | - |
| A1 | 1967 | | - | - |
| A2 | 1977 | | - | - |
| IEC 60068-1 | 1988 | Environmental testing Part 1: General and guidance | EN 60068-1 | 1994 ¹⁾ |
| IEC 60068-2-58 | 1999 | Part 2-58: Tests - Test Td: Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD) | EN 60068-2-58 | 1999 ²⁾ |
| IEC 60384-1 (mod) | 1999 | Fixed capacitors for use in electronic equipment Part 1: Generic specification | EN 60384-1 + corr. October | 2001 2001 |
| IEC 60410 | 1973 | Sampling plans and procedures for inspection by attributes | - | - |
| IEC QC 001005 | 2000 | Register of firms, products and services approved under the IECQ system, including ISO 9000 | - | - |
| ISO 3 | 1973 | Preferred numbers - Series of preferred numbers | - | - |

¹⁾ EN 60068-1 includes corrigendum October 1988 + A1:1992 to IEC 60068-1.

²⁾ EN 60068-2-58:1999 is superseded by EN 60068-2-58:2004, which is based on IEC 60068-2-58:2004.

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INTERNATIONAL STANDARD

IEC 60384-22

First edition
2004-06

Fixed capacitors for use in electronic equipment –

Part 22:

Sectional specification:

Fixed surface mount multilayer capacitors

of ceramic dielectric, Class 2

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Международная Электротехническая Комиссия

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CONTENTS

| | |
|--|----|
| FOREWORD | 4 |
| 1 General | 6 |
| 1.1 Scope | 6 |
| 1.2 Object | 6 |
| 1.3 Normative references | 6 |
| 1.4 Information to be given in a detail specification | 7 |
| 1.5 Terminology | 8 |
| 1.6 Marking | 9 |
| 2 Preferred rating and characteristics | 9 |
| 2.1 Preferred characteristics | 9 |
| 2.2 Preferred values of ratings | 10 |
| 3 Quality assessment procedures | 11 |
| 3.1 Primary stage of manufacture | 11 |
| 3.2 Structurally similar components | 11 |
| 3.3 Certified records of released lots | 11 |
| 3.4 Qualification Approval | 12 |
| 3.5 Quality Conformance Inspection | 18 |
| 4 Test and measurement procedures | 20 |
| 4.1 Special preconditioning | 20 |
| 4.2 Measuring conditions | 20 |
| 4.3 Mounting | 20 |
| 4.4 Visual examination and check of dimensions | 20 |
| 4.5 Electrical tests | 22 |
| 4.6 Temperature characteristic of capacitance | 25 |
| 4.7 Shear test | 26 |
| 4.8 Substrate bending test | 26 |
| 4.9 Resistance to soldering heat | 27 |
| 4.10 Solderability | 28 |
| 4.11 Rapid change of temperature | 29 |
| 4.12 Climatic sequence | 30 |
| 4.13 Damp heat, steady state | 31 |
| 4.14 Endurance | 32 |
| 4.15 Robustness of terminations (only for capacitors with strip termination) | 33 |
| 4.16 Component solvent resistance (if required) | 33 |
| 4.17 Solvent resistance of the marking (if required) | 33 |
| 4.18 Accelerated damp heat, steady state (if required) | 34 |
| Annex A (normative) Guide for the specification and coding of dimensions of fixed surface mount multilayer capacitors of ceramic dielectric, Class 2 | 36 |
| Annex B (informative) Capacitance ageing of fixed capacitors of ceramic dielectric, Class 2 | 37 |

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 (standards.iteh.ai)
 SIST EN 60384-22:2005
<https://standards.iteh.ai/catalog/standards/sist/748bbbf-875c-4d8a-9fbb-b947e206299e/sist-en-60384-22-2005>

| | |
|--|----|
| Figure 1 – Fault: crack or fissure | 21 |
| Figure 2 – Fault: crack or fissure | 21 |
| Figure 3 – Separation or delamination | 21 |
| Figure 4 – Exposed electrodes..... | 21 |
| Figure 5 – Principal faces | 22 |
| | |
| Table 1 – Preferred values of category voltages | 10 |
| Table 2 – Preferred tolerances..... | 10 |
| Table 3 – Temperature characteristic of capacitance | 11 |
| Table 4 – Fixed sample size test plan for qualification approval, assessment level EZ..... | 14 |
| Table 5 – Tests schedule for qualification approval..... | 15 |
| Table 6a – Lot-by-lot inspection | 19 |
| Table 6b – Periodic test | 19 |
| Table 7 – Measuring conditions | 22 |
| Table 8 – Tangent of loss angle limits..... | 23 |
| Table 9 – Test voltages..... | 24 |
| Table 10 – Details of measuring conditions..... | 26 |
| Table 11 – Maximum capacitance change..... | 28 |
| Table 12 – Maximum capacitance change..... | 29 |
| Table 13 – Number of damp heat cycles | 30 |
| Table 14 – Final inspection, measurements and requirements | 31 |
| Table 15 – Final inspection, measurements and requirements | 32 |
| Table 16 – Endurance test conditions ($U_C = U_R$)..... | 32 |
| Table 17 – Endurance test conditions ($U_C \neq U_R$)..... | 32 |
| Table 18 – Final inspection, measurements and requirements of endurance test | 33 |
| Table 19 – Initial requirements..... | 34 |
| Table 20 – Conditioning | 34 |
| Table A.1 – Dimensions | 36 |

INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –

**Part 22: Sectional specification:
Fixed surface mount multilayer capacitors
of ceramic dielectric, Class 2**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 60384-22 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This standard and its related publications (CEI 60384-21, IEC 60384-21-1 and IEC 60384-22-1) cancel and replace IEC 60384-10 (1989) and its Amendments 1 (1993) and 2 (2000) as well as IEC 60384-10-1 (1989) and its Amendment 1 (1993).

The text of this standard is based on the following documents:

| FDIS | Report on voting |
|--------------|------------------|
| 40/1422/FDIS | 40/1453/RVD |

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

A bilingual version of this standard may be issued at a later date.

The contents of the corrigendum of September 2004 have been included in this copy.

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FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –

Part 22: Sectional specification: Fixed surface mount multilayer capacitors of ceramic dielectric, Class 2

1 General

1.1 Scope

This sectional specification is applicable to fixed unencapsulated surface mount multilayer capacitors of ceramic dielectric, Class 2, for use in electronic equipment. These capacitors have metallized connecting pads or soldering strips and are intended to be mounted on printed boards, or directly onto substrates for hybrid circuits.

Capacitors for electromagnetic interference suppression are not included, but are covered by IEC 60384-14.

1.2 Object

The object of this standard is to prescribe preferred ratings and characteristics and to select from IEC 60384-1:1999 the appropriate quality assessment procedures, tests and measuring methods and to give general performance requirements for this type of capacitor. Test severities and requirements prescribed in detail specifications referring to this sectional specification shall be of equal or higher performance level, lower performance levels are not permitted.

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1.3 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60063:1963, *Preferred number series for resistors and capacitors*
Amendment 1 (1967)
Amendment 2 (1977)

IEC 60068-1:1988, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-58:1999, *Environmental testing – Part 2-58: Tests – Test Td – Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)*

IEC 60384-1:1999, *Fixed capacitors for use in electronic equipment – Part 1: Generic specification*

IEC 60410:1973, *Sampling plans and procedures for inspection by attributes*

IEC QC 001005: *Register of firms, products and services approved under the IECQ system, including ISO 9000*

ISO 3:1973, *Preferred numbers – Series of preferred numbers*

1.4 Information to be given in a detail specification

Detail specifications shall be derived from the relevant blank detail specification.

Detail specifications shall not specify requirements inferior to those of the generic, sectional or blank detail specification. When more severe requirements are included, they shall be listed in 1.9 of the detail specification and indicated in the test schedules, for example by an asterisk.

NOTE The information given in 1.4.1 may for convenience, be presented in tabular form.

The following information shall be given in each detail specification and the values quoted shall preferably be selected from those given in the appropriate Clause of this sectional specification.

1.4.1 Outline drawing and dimensions

There shall be an illustration of the capacitors as an aid to easy recognition and for comparison of the capacitors with others.

Dimensions and their associated tolerances, which affect interchangeability and mounting, shall be given in the detail specification. All dimensions shall preferably be stated in millimetres, however, when the original dimensions are given in inches, the converted metric dimensions in millimetres shall be added.

Normally the numerical values shall be given for the length, width and height of the body. When necessary, for example when a number of items (sizes and capacitance/voltage ranges) are covered by a detail specification, the dimensions and their associated tolerances shall be placed in a table below the drawing.

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When the configuration is other than described above, the detail specification shall state such dimensional information as will adequately describe the capacitors.

1.4.2 Mounting

The detail specification shall give guidance on methods of mounting for normal use. Mounting for test and measurement purposes (when required) shall be in accordance with 4.3 of this sectional specification.

1.4.3 Rating and characteristics

The ratings and characteristics shall be in accordance with the relevant Clauses of this specification, together with the following:

1.4.3.1 Rated capacitance range

See 2.2.4.1.

NOTE When products approved to the detail specification have different ranges, the following statement should be added: "The range of capacitance values available in each voltage range is given in IECQ 001005".

1.4.3.2 Particular characteristics

Additional characteristics may be listed, when they are considered necessary to specify adequately the component for design and application purposes.

1.4.3.3 Soldering

The detail specification shall prescribe the test methods, severities and requirements applicable for the solderability and the resistance to soldering heat tests.

1.4.4 Marking

The detail specification shall specify the content of the marking on the capacitor and on the package. Deviations from 1.6 of this sectional specification shall be specifically stated.

1.5 Terms and definitions

For the purposes of this sectional specification, the terms and definitions given in IEC 60384-1, as well as the following apply.

1.5.1

surface mount capacitor

a capacitor whose small dimensions and nature or shape of terminations make it suitable for surface mounting in hybrid circuits and on printed boards

1.5.2

fixed capacitors, ceramic dielectric, Class 2

capacitor which has a dielectric with a high permittivity and is suitable for by-pass and coupling applications or for frequency discriminating circuits where low losses and high stability of capacitance are not of major importance.

The ceramic dielectric is characterized by a non linear change of capacitance over the category temperature range (see Table 3).

1.5.3

subclass

maximum percentage change of capacitance within the category temperature range with respect to the capacitance at 20 °C.

The subclass may be expressed in code form (see Table 3)

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1.5.4

category temperature range

range of ambient temperatures for which the capacitor has been designed to operate continuously; this is given by the lower and upper category temperature

1.5.5

rated temperature

maximum ambient temperature at which the rated voltage may be continuously applied

1.5.6

rated voltage (d.c.)

U_R

maximum direct voltage or peak value of pulse voltage which may be applied continuously to a capacitor at any temperature between the lower category temperature and the rated temperature

NOTE The sum of the d.c. voltage and the peak a.c. voltage or the peak to peak a.c. voltage, whichever is the greater, applied to the capacitor shall not exceed the rated voltage. The value of the peak a.c. voltage shall not exceed the value determined by the permissible reactive power.

1.5.7

category voltage

U_C

maximum voltage which may be applied continuously to a capacitor at its upper category temperature

1.6 Marking

See 2.4 of IEC 60384-1 with the following details:

1.6.1 The information given in the marking is normally selected from the following list; the relative importance of each item is indicated by its position in the list:

- a) rated capacitance;
- b) rated voltage (d.c. voltage may be indicated by the symbol ($\overline{\text{---}}$ or ---);
- c) tolerance on rated capacitance;
- d) dielectric subclass as applicable (according to 2.2.5);
- e) year and month (or week) of manufacture;
- f) manufacturer's name or trade mark;
- g) climatic category;
- h) manufacturer's type designation;
- i) reference to the detail specification.

1.6.2 These capacitors are generally not marked on the body. If some marking can be applied, they shall be clearly marked with as many as possible of the above items as is considered useful. Any duplication of information in the marking on the capacitor should be avoided.

1.6.3 Any marking shall be legible and not easily smeared or removed by rubbing with the finger.

1.6.4 The package containing the capacitor(s) shall be clearly marked with all the information listed in 1.6.1.

1.6.5 Any additional marking shall be so applied that no confusion can arise.

2 Preferred rating and characteristics

2.1 Preferred characteristics

The values given in the detail specification shall preferably be selected from the following:

2.1.1 Preferred climatic categories

The capacitors covered by this sectional specification are classified into climatic categories according to the general rules given in IEC 60068-1.

The lower and upper category temperatures and the duration of the damp heat, steady state test shall be chosen from the following:

Lower category temperature: $-55\text{ }^{\circ}\text{C}$, $-40\text{ }^{\circ}\text{C}$, $-25\text{ }^{\circ}\text{C}$, $-10\text{ }^{\circ}\text{C}$ and $+10\text{ }^{\circ}\text{C}$

Upper category temperature: $+70\text{ }^{\circ}\text{C}$, $+85\text{ }^{\circ}\text{C}$, $+100\text{ }^{\circ}\text{C}$, $+125\text{ }^{\circ}\text{C}$ and $+150\text{ }^{\circ}\text{C}$

Duration of the damp heat, steady state test: 4, 10, 21 and 56 days.

The severities for the cold and dry heat tests are the lower and upper category temperatures respectively.

NOTE The resistance to humidity resulting from the above climatic category is for the capacitors in their unmounted state. The climatic performance of the capacitors after mounting is greatly influenced by the mounting substrate, the mounting method (see 4.3) and the final coating.